

# BIPOLAR ANALOG INTEGRATED CIRCUIT

# $\mu$ PC78N00 SERIES

## THREE TERMINAL POSITIVE VOLTAGE REGULATOR

### DESCRIPTION

$\mu$ PC78N00 series are monolithic three terminal positive regulators which employ internally current limiting, thermal shut down, output transistor safe operating area protection make them essentially indestructible.

They are intended as fixed voltage regulators in a wide range of application including local on card regulation for elimination of distribution problems associated wide single point regulation.

### FEATURES

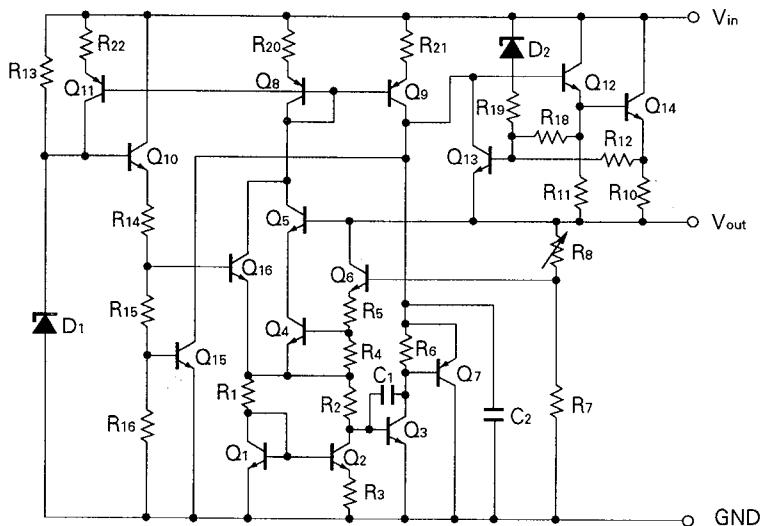
- Output current in excess of 300 mA.
- Built-in some protection circuits.  
(over current protection, SOA protection and thermal shut down)
- Small package, TO-126

### ORDER INFORMATION

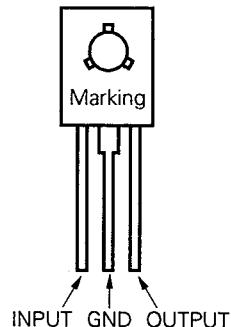
Type Number	Output Voltage	Package	Quality Grade
$\mu$ PC78N05H	5 V	TO-126	Standard
$\mu$ PC78N08H	8 V		
$\mu$ PC78N10H	10 V		
$\mu$ PC78N12H	12 V		
$\mu$ PC78N15H	15 V		
$\mu$ PC78N18H	18 V		
$\mu$ PC78N24H	24 V		

Please refer to "Quality grade on NEC Semiconductor Devices" (Document number IEI-1209) published by NEC Corporation to know the specification of quality grade on the devices and its recommended applications.

### EQUIVALENT CIRCUIT



### CONNECTION DIAGRAM



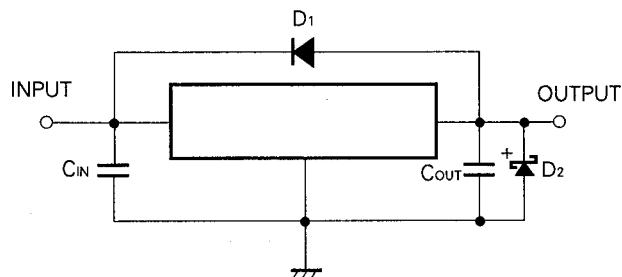
ABSOLUTE MAXIMUM RATINGS ( $T_a = 25^\circ\text{C}$ )

CHARACTERISTIC	SYMBOL	RATING	UNIT
Input Voltage	$V_{IN}$	35/40 (Note1)	V
Internal Power Dissipation	$P_T$	12.5 (Note2)	W
Operating Ambient Temperature Range	$T_{opt}$	-20 to +85	$^\circ\text{C}$
Operating Junction Temperature Range	$T_{opt(j)}$	-20 to +150	$^\circ\text{C}$
Storage Temperature Range	$T_{stg}$	-55 to +150	$^\circ\text{C}$
Thermal Resistance (junction to case)	$R_{th(j-c)}$	10	$^\circ\text{C}/\text{W}$
Thermal Resistance (junction to ambient)	$R_{th(j-a)}$	110	$^\circ\text{C}/\text{W}$

(Note 1)  $\mu$ PC78N05, 08, 10, 12, 15, 18 : 35 V,  $\mu$ PC78N24 : 40 V

(Note 2) Internally limited

## TYPICAL CONNECTION



C1: Required if regulator is located an appreciable distance from power supply filter

C2: More than 0.1  $\mu\text{F}$ D1: Needed for  $V_{IN} < V_o$ D2: Needed for  $V_o < \text{GND}$ 

## RECOMMENDED OPERATING CONDITIONS

CHARACTERISTIC	SYMBOL	TYPE NUMBER	MIN.	TYP.	MAX.	UNIT
Input Voltage	$V_{IN}$	$\mu$ PC78N05H	7	10	25	V
		$\mu$ PC78N08H	10.5	14	25	
		$\mu$ PC78N10H	12.5	17	30	
		$\mu$ PC78N12H	14.5	19	30	
		$\mu$ PC78N15H	17.5	23	30	
		$\mu$ PC78N18H	21	27	33	
		$\mu$ PC78N24H	27	33	38	
Output Current	$I_o$	All	0		300	mA
Operating Temperature Range	$T_{opt}$	All	-20		+85	$^\circ\text{C}$
Operating Junction Temperature Range	$T_{opt(j)}$	All	-20		+125	$^\circ\text{C}$

ELECTRICAL CHARACTERISTICS  $\mu$ PC78N05(V<sub>IN</sub> = 10 V, I<sub>O</sub> = 200 mA, 0 °C ≤ T<sub>j</sub> ≤ +125 °C, C<sub>IN</sub> = 0.33 μF, C<sub>OUT</sub> = 0.1 μF)

CHARACTERISTIC	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Output Voltage	V <sub>O</sub>	T <sub>j</sub> = 25 °C	4.8	5.0	5.2	V
		7 V ≤ V <sub>IN</sub> ≤ 20 V, 5 mA ≤ I <sub>O</sub> ≤ 200 mA	4.75		5.25	
Line Regulation	REG <sub>IN</sub>	T <sub>j</sub> = 25 °C, 7 V ≤ V <sub>IN</sub> ≤ 25 V		15	50	mV
		T <sub>j</sub> = 25 °C, 8 V ≤ V <sub>IN</sub> ≤ 20 V		10	25	
Load Regulation	REG <sub>L</sub>	T <sub>j</sub> = 25 °C, 1 mA ≤ I <sub>O</sub> ≤ 300 mA		6	100	mV
		T <sub>j</sub> = 25 °C, 5 mA ≤ I <sub>O</sub> ≤ 200 mA		4	50	
Quiescent Current	I <sub>BIAS</sub>	T <sub>j</sub> = 25 °C		3.5	5.0	mA
Quiescent Current Change	ΔI <sub>BIAS</sub>	7 V ≤ V <sub>IN</sub> ≤ 25 V			0.8	mA
		1 mA ≤ I <sub>O</sub> ≤ 300 mA			0.5	
Output Noise Voltage	V <sub>n</sub>	T <sub>j</sub> = 25 °C, 10 Hz ≤ f ≤ 100 kHz		50	120	μV <sub>r.m.s.</sub>
Ripple Rejection	R · R	T <sub>j</sub> = 25 °C, f = 120 Hz, 8 V ≤ V <sub>IN</sub> ≤ 18 V	62	70		dB
Dropout Voltage	V <sub>DIF</sub>	T <sub>j</sub> = 25 °C		1.7		V
Short Circuit Current	I <sub>Oshort</sub>	T <sub>j</sub> = 25 °C, V <sub>IN</sub> = 25 V		170		mA
Peak Output Current	I <sub>Opeak</sub>	T <sub>j</sub> = 25 °C	360	500	640	mA
Temperature coefficient of Output Voltage	ΔV <sub>O</sub> / ΔT	I <sub>O</sub> = 5 mA		0.1		mV/°C

ELECTRICAL CHARACTERISTICS  $\mu$ PC78N08(V<sub>IN</sub> = 14 V, I<sub>O</sub> = 200 mA, 0 °C ≤ T<sub>j</sub> ≤ +125 °C, C<sub>IN</sub> = 0.33 μF, C<sub>OUT</sub> = 0.1 μF)

CHARACTERISTIC	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Output Voltage	V <sub>O</sub>	T <sub>j</sub> = 25 °C	7.7	8.0	8.3	V
		10.5 V ≤ V <sub>IN</sub> ≤ 23 V, 5 mA ≤ I <sub>O</sub> ≤ 200 mA	7.6		8.4	
Line Regulation	REG <sub>IN</sub>	T <sub>j</sub> = 25 °C, 10.5 V ≤ V <sub>IN</sub> ≤ 25 V		18	80	mV
		T <sub>j</sub> = 25 °C, 12 V ≤ V <sub>IN</sub> ≤ 23 V		13	40	
Load Regulation	REG <sub>L</sub>	T <sub>j</sub> = 25 °C, 1 mA ≤ I <sub>O</sub> ≤ 300 mA		8	160	mV
		T <sub>j</sub> = 25 °C, 5 mA ≤ I <sub>O</sub> ≤ 200 mA		6	80	
Quiescent Current	I <sub>BIAS</sub>	T <sub>j</sub> = 25 °C		3.5	5.0	mA
Quiescent Current Change	ΔI <sub>BIAS</sub>	10.5 V ≤ V <sub>IN</sub> ≤ 25 V			0.8	mA
		1 mA ≤ I <sub>O</sub> ≤ 300 mA			0.5	
Output Noise Voltage	V <sub>n</sub>	T <sub>j</sub> = 25 °C, 10 Hz ≤ f ≤ 100 kHz		65	190	μV <sub>r.m.s.</sub>
Ripple Rejection	R · R	T <sub>j</sub> = 25 °C, f = 120 Hz, 11 V ≤ V <sub>IN</sub> ≤ 21 V	56	68		dB
Dropout Voltage	V <sub>DIF</sub>	T <sub>j</sub> = 25 °C		1.7		V
Short Circuit Current	I <sub>Oshort</sub>	T <sub>j</sub> = 25 °C, V <sub>IN</sub> = 25 V		170		mA
Peak Output Current	I <sub>Opeak</sub>	T <sub>j</sub> = 25 °C	360	490	640	mA
Temperature coefficient of Output Voltage	ΔV <sub>O</sub> / ΔT	I <sub>O</sub> = 5 mA		0.2		mV/°C

**ELECTRICAL CHARACTERISTICS  $\mu$ PC78N10**(V<sub>IN</sub> = 17 V, I<sub>O</sub> = 200 mA, 0 °C ≤ T<sub>j</sub> ≤ + 125 °C, C<sub>IN</sub> = 0.33 μF, C<sub>OUT</sub> = 0.1 μF)

CHARACTERISTIC	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Output Voltage	V <sub>O</sub>	T <sub>j</sub> = 25 °C	9.6	10	10.4	V
		12.5 V ≤ V <sub>IN</sub> ≤ 25 V, 5 mA ≤ I <sub>O</sub> ≤ 200 mA	9.5		10.5	
Line Regulation	REG <sub>IN</sub>	T <sub>j</sub> = 25 °C, 12.5 V ≤ V <sub>IN</sub> ≤ 30 V		25	100	mV
		T <sub>j</sub> = 25 °C, 13 V ≤ V <sub>IN</sub> ≤ 25 V		17	50	
Load Regulation	REG <sub>L</sub>	T <sub>j</sub> = 25 °C, 1 mA ≤ I <sub>O</sub> ≤ 300 mA		12	200	mV
		T <sub>j</sub> = 25 °C, 5 mA ≤ I <sub>O</sub> ≤ 200 mA		8	100	
Quiescent Current	I <sub>BIA</sub> S	T <sub>j</sub> = 25 °C		3.6	5.0	mA
Quiescent Current Change	ΔI <sub>BIA</sub> S	13 V ≤ V <sub>IN</sub> ≤ 30 V			0.8	mA
		1 mA ≤ I <sub>O</sub> ≤ 300 mA			0.5	
Output Noise Voltage	V <sub>n</sub>	T <sub>j</sub> = 25 °C, 10 Hz ≤ f ≤ 100 kHz		80	230	μV <sub>r.m.s.</sub>
Ripple Rejection	R · R	T <sub>j</sub> = 25 °C, f = 120 Hz, 13 V ≤ V <sub>IN</sub> ≤ 23 V	56	66		dB
Dropout Voltage	V <sub>DIF</sub>	T <sub>j</sub> = 25 °C		1.7		V
Short Circuit Current	I <sub>Oshort</sub>	T <sub>j</sub> = 25 °C, V <sub>IN</sub> = 30 V		100		mA
Peak Output Current	I <sub>Opeak</sub>	T <sub>j</sub> = 25 °C	360	480	640	mA
Temperature coefficient of Output Voltage	ΔV <sub>O</sub> /ΔT	I <sub>O</sub> = 5 mA		0.2		mV/°C

**ELECTRICAL CHARACTERISTICS  $\mu$ PC78N12**(V<sub>IN</sub> = 19 V, I<sub>O</sub> = 200 mA, 0 °C ≤ T<sub>j</sub> ≤ + 125 °C, C<sub>IN</sub> = 0.33 μF, C<sub>OUT</sub> = 0.1 μF)

CHARACTERISTIC	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Output Voltage	V <sub>O</sub>	T <sub>j</sub> = 25 °C	11.5	12	12.5	V
		14.5 V ≤ V <sub>IN</sub> ≤ 27 V, 5 mA ≤ I <sub>O</sub> ≤ 200 mA	11.4		12.6	
Line Regulation	REG <sub>IN</sub>	T <sub>j</sub> = 25 °C, 14.5 V ≤ V <sub>IN</sub> ≤ 30 V		30	100	mV
		T <sub>j</sub> = 25 °C, 16 V ≤ V <sub>IN</sub> ≤ 27 V		20	50	
Load Regulation	REG <sub>L</sub>	T <sub>j</sub> = 25 °C, 1 mA ≤ I <sub>O</sub> ≤ 300 mA		18	240	mV
		T <sub>j</sub> = 25 °C, 5 mA ≤ I <sub>O</sub> ≤ 200 mA		12	120	
Quiescent Current	I <sub>BIA</sub> S	T <sub>j</sub> = 25 °C		3.6	5.0	mA
Quiescent Current Change	ΔI <sub>BIA</sub> S	14.5 V ≤ V <sub>IN</sub> ≤ 30 V			0.8	mA
		1 mA ≤ I <sub>O</sub> ≤ 300 mA			0.5	
Output Noise Voltage	V <sub>n</sub>	T <sub>j</sub> = 25 °C, 10 Hz ≤ f ≤ 100 kHz		90	280	μV <sub>r.m.s.</sub>
Ripple Rejection	R · R	T <sub>j</sub> = 25 °C, f = 120 Hz, 15 V ≤ V <sub>IN</sub> ≤ 25 V	55	64		dB
Dropout Voltage	V <sub>DIF</sub>	T <sub>j</sub> = 25 °C		1.7		V
Short Circuit Current	I <sub>Oshort</sub>	T <sub>j</sub> = 25 °C, V <sub>IN</sub> = 30 V		100		mA
Peak Output Current	I <sub>Opeak</sub>	T <sub>j</sub> = 25 °C	360	480	640	mA
Temperature coefficient of Output Voltage	ΔV <sub>O</sub> /ΔT	I <sub>O</sub> = 5 mA		0.3		mV/°C

ELECTRICAL CHARACTERISTICS  $\mu$ PC78N15(V<sub>IN</sub> = 23 V, I<sub>O</sub> = 200 mA, 0 °C ≤ T<sub>j</sub> ≤ +125 °C, C<sub>IN</sub> = 0.33 μF, C<sub>OUT</sub> = 0.1 μF)

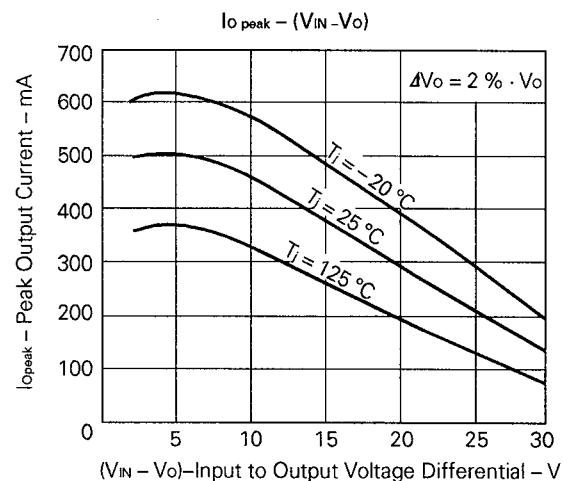
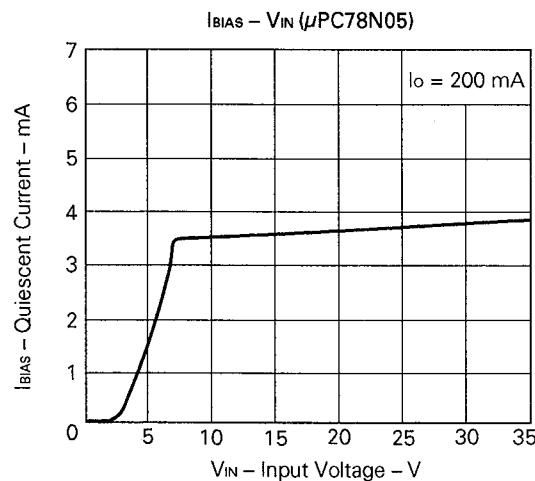
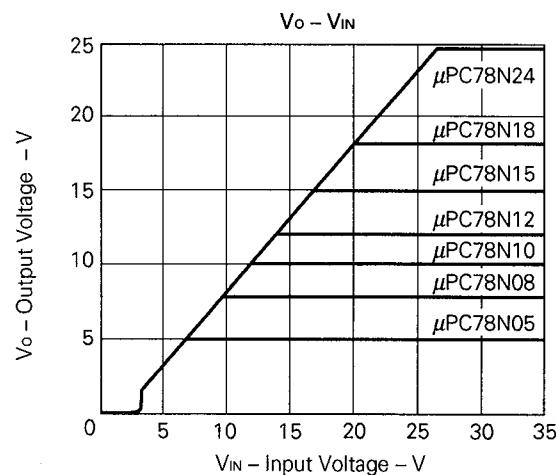
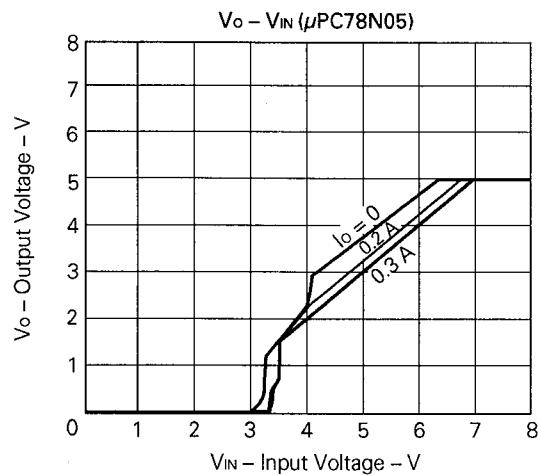
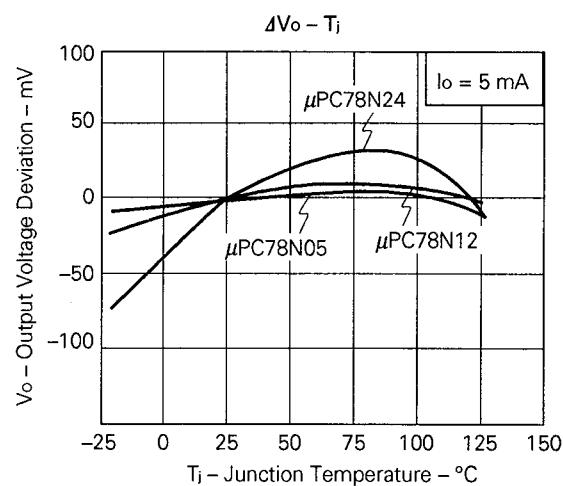
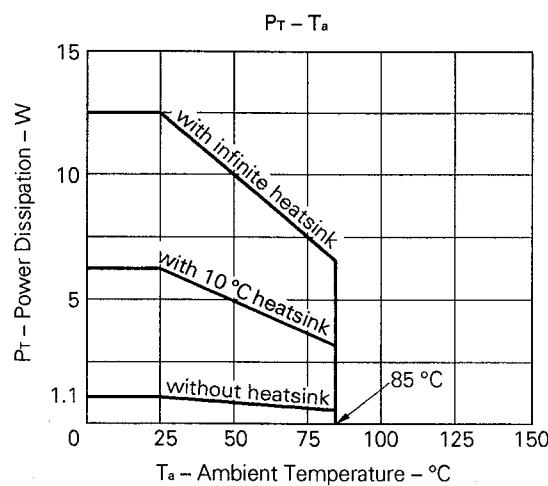
CHARACTERISTIC	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Output Voltage	V <sub>O</sub>	T <sub>j</sub> = 25 °C	14.4	15	15.6	V
		17.5 V ≤ V <sub>IN</sub> ≤ 30 V, 5 mA ≤ I <sub>O</sub> ≤ 200 mA	14.25		15.75	
Line Regulation	REG <sub>IN</sub>	T <sub>j</sub> = 25 °C, 17.5 V ≤ V <sub>IN</sub> ≤ 30 V		32	100	mV
		T <sub>j</sub> = 25 °C, 20 V ≤ V <sub>IN</sub> ≤ 30 V		25	50	
Load Regulation	REG <sub>L</sub>	T <sub>j</sub> = 25 °C, 1 mA ≤ I <sub>O</sub> ≤ 300 mA		25	300	mV
		T <sub>j</sub> = 25 °C, 5 mA ≤ I <sub>O</sub> ≤ 200 mA		16	150	
Quiescent Current	I <sub>BIAS</sub>	T <sub>j</sub> = 25 °C		3.7	5.0	mA
Quiescent Current Change	ΔI <sub>BIAS</sub>	17.5 V ≤ V <sub>IN</sub> ≤ 30 V			0.8	mA
		1 mA ≤ I <sub>O</sub> ≤ 300 mA			0.5	
Output Noise Voltage	V <sub>n</sub>	T <sub>j</sub> = 25 °C, 10 Hz ≤ f ≤ 100 kHz		100	350	μV <sub>r.m.s.</sub>
Ripple Rejection	R · R	T <sub>j</sub> = 25 °C, f = 120 Hz, 18.5 V ≤ V <sub>IN</sub> ≤ 28.5 V	54	62		dB
Dropout Voltage	V <sub>DIF</sub>	T <sub>j</sub> = 25 °C		1.7		V
Short Circuit Current	I <sub>Oshort</sub>	T <sub>j</sub> = 25 °C, V <sub>IN</sub> = 30 V		100		mA
Peak Output Current	I <sub>Opeak</sub>	T <sub>j</sub> = 25 °C	360	470	640	mA
Temperature coefficient of Output Voltage	ΔV <sub>O</sub> /ΔT	I <sub>O</sub> = 5 mA		0.5		mV/°C

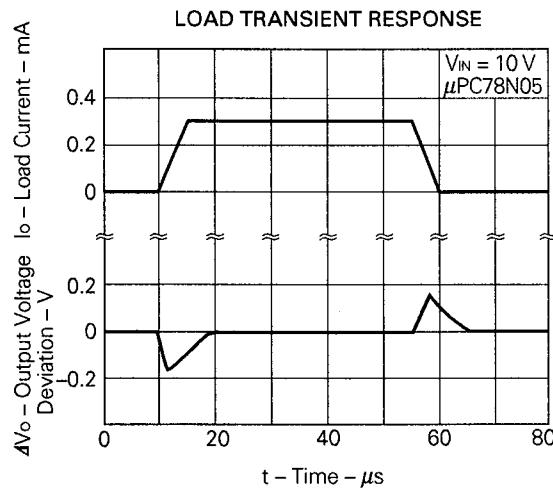
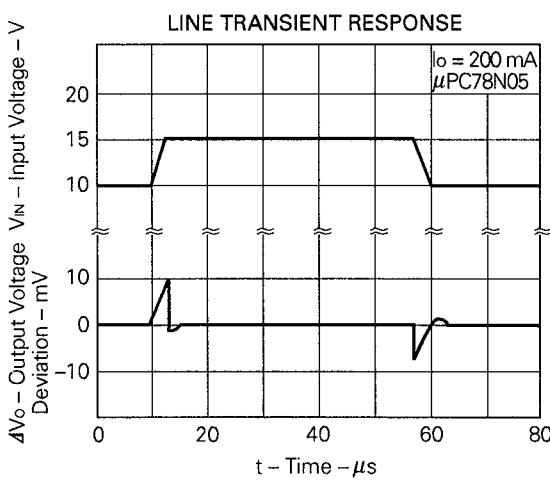
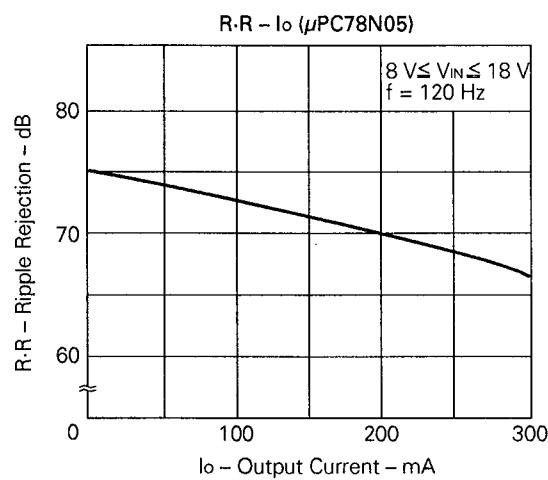
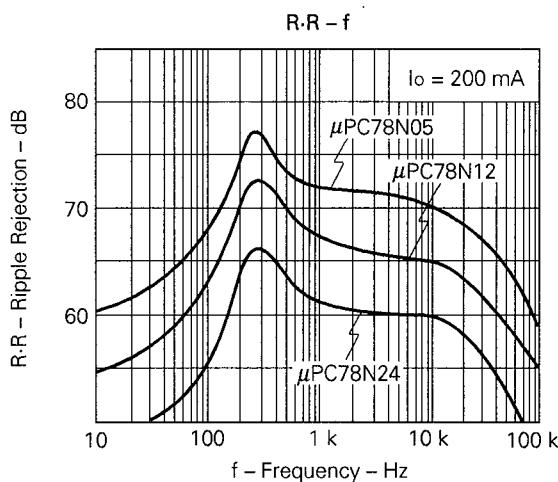
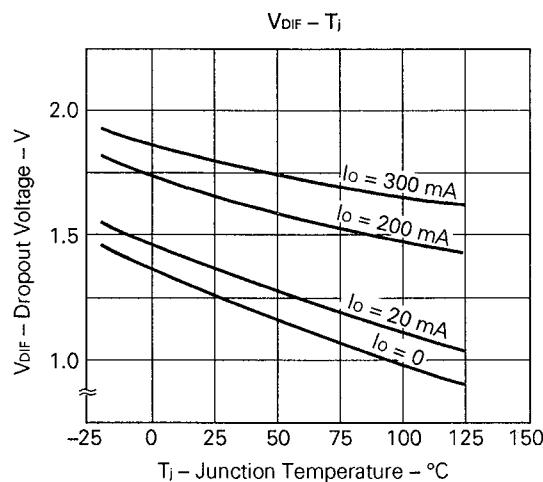
ELECTRICAL CHARACTERISTICS  $\mu$ PC78N18(V<sub>IN</sub> = 27 V, I<sub>O</sub> = 200 mA, 0 °C ≤ T<sub>j</sub> ≤ +125 °C, C<sub>IN</sub> = 0.33 μF, C<sub>OUT</sub> = 0.1 μF)

CHARACTERISTIC	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Output Voltage	V <sub>O</sub>	T <sub>j</sub> = 25 °C	17.3	18	18.7	V
		21 V ≤ V <sub>IN</sub> ≤ 33 V, 5 mA ≤ I <sub>O</sub> ≤ 200 mA	17.1		18.9	
Line Regulation	REG <sub>IN</sub>	T <sub>j</sub> = 25 °C, 21 V ≤ V <sub>IN</sub> ≤ 33 V		32	100	mV
		T <sub>j</sub> = 25 °C, 22 V ≤ V <sub>IN</sub> ≤ 33 V		25	50	
Load Regulation	REG <sub>L</sub>	T <sub>j</sub> = 25 °C, 1 mA ≤ I <sub>O</sub> ≤ 300 mA		30	360	mV
		T <sub>j</sub> = 25 °C, 5 mA ≤ I <sub>O</sub> ≤ 200 mA		20	180	
Quiescent Current	I <sub>BIAS</sub>	T <sub>j</sub> = 25 °C		3.7	5.0	mA
Quiescent Current Change	ΔI <sub>BIAS</sub>	21 V ≤ V <sub>IN</sub> ≤ 33 V			0.8	mA
		1 mA ≤ I <sub>O</sub> ≤ 300 mA			0.5	
Output Noise Voltage	V <sub>n</sub>	T <sub>j</sub> = 25 °C, 10 Hz ≤ f ≤ 100 kHz		115	420	μV <sub>r.m.s.</sub>
Ripple Rejection	R · R	T <sub>j</sub> = 25 °C, f = 120 Hz, 22 V ≤ V <sub>IN</sub> ≤ 32 V	53	60		dB
Dropout Voltage	V <sub>DIF</sub>	T <sub>j</sub> = 25 °C		1.7		V
Short Circuit Current	I <sub>Oshort</sub>	T <sub>j</sub> = 25 °C, V <sub>IN</sub> = 33 V		60		mA
Peak Output Current	I <sub>Opeak</sub>	T <sub>j</sub> = 25 °C	360	460	640	mA
Temperature coefficient of Output Voltage	ΔV <sub>O</sub> /ΔT	I <sub>O</sub> = 5 mA		0.5		mV/°C

ELECTRICAL CHARACTERISTICS  $\mu$ PC78N24(V<sub>IN</sub> = 33 V, I<sub>O</sub> = 200 mA, 0 °C ≤ T<sub>j</sub> ≤ + 125 °C, C<sub>IN</sub> = 0.33 μF, C<sub>OUT</sub> = 0.1 μF)

CHARACTERISTIC	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Output Voltage	V <sub>O</sub>	T <sub>j</sub> = 25 °C	23	24	25	V
		27 V ≤ V <sub>IN</sub> ≤ 38 V, 5 mA ≤ I <sub>O</sub> ≤ 200 mA	22.8		25.2	
Line Regulation	REG <sub>IN</sub>	T <sub>j</sub> = 25 °C, 27 V ≤ V <sub>IN</sub> ≤ 38 V		40	100	mV
		T <sub>j</sub> = 25 °C, 28 V ≤ V <sub>IN</sub> ≤ 38 V		30	50	
Load Regulation	REG <sub>L</sub>	T <sub>j</sub> = 25 °C, 1 mA ≤ I <sub>O</sub> ≤ 300 mA		35	480	mV
		T <sub>j</sub> = 25 °C, 5 mA ≤ I <sub>O</sub> ≤ 200 mA		23	240	
Quiescent Current	I <sub>BIAS</sub>	T <sub>j</sub> = 25 °C		3.7	5.0	mA
Quiescent Current Change	ΔI <sub>BIAS</sub>	27 V ≤ V <sub>IN</sub> ≤ 38 V			0.8	mA
		1 mA ≤ I <sub>O</sub> ≤ 300 mA			0.5	
Output Noise Voltage	V <sub>n</sub>	T <sub>j</sub> = 25 °C, 10 Hz ≤ f ≤ 100 kHz		135	560	μV <sub>r.m.s.</sub>
Ripple Rejection	R · R	T <sub>j</sub> = 25 °C, f = 120 Hz, 28 V ≤ V <sub>IN</sub> ≤ 38 V	50	57		dB
Dropout Voltage	V <sub>DIF</sub>	T <sub>j</sub> = 25 °C		1.7		V
Short Circuit Current	I <sub>Oshort</sub>	T <sub>j</sub> = 25 °C, V <sub>IN</sub> = 38 V		5		mA
Peak Output Current	I <sub>Opeak</sub>	T <sub>j</sub> = 25 °C	360	460	640	mA
Temperature coefficient of Output Voltage	ΔV <sub>O</sub> /ΔT	I <sub>O</sub> = 5 mA		0.7		mV/°C

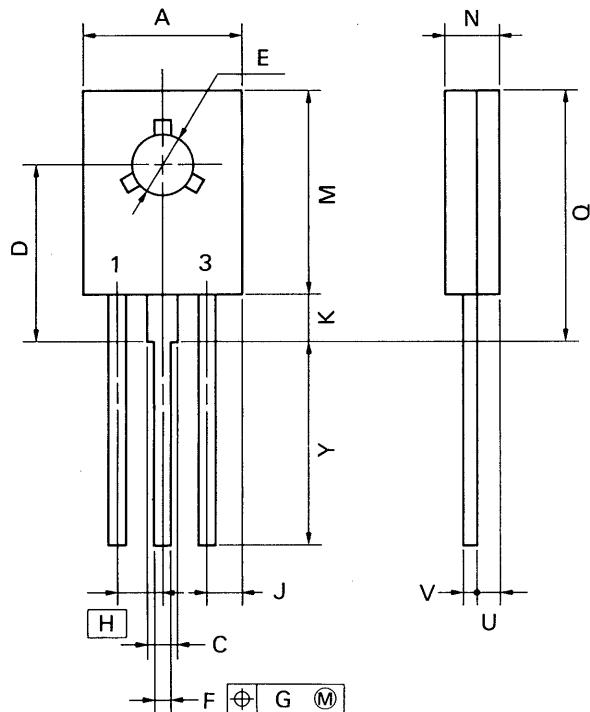
TYPICAL CHARACTERISTICS ( $T_a = 25^\circ\text{C}$ )



## PACKAGE DIMENSIONS (Unit: mm)

 $\mu$ PC78N00H Series

3 PIN PLASTIC SIP (TO-126)



P3HP-230B

## NOTE

Each lead centerline is located within 0.23 mm (0.009 inch) of its true position (T.P.) at maximum material condition.

ITEM	MILLIMETERS	INCHES
A	8.5 MAX.	0.335 MAX.
C	1.1 MIN.	0.043 MIN.
D	$9.7 \pm 0.3$	$0.382 \pm 0.012$
E	$\phi 3.2 \pm 0.1$	$\phi 0.126 \pm 0.004$
F	$0.80 \pm 0.1$	$0.031 \pm 0.004$
G	0.23	0.009
H	2.3	0.091
J	1.95 MAX.	0.077 MAX.
K	2.3 MIN.	0.09 MIN.
M	11.5 MAX.	0.453 MAX.
N	$2.7 \pm 0.2$	$0.106 \pm 0.008$
Q	14.5 MAX.	0.571 MAX.
U	1.7 MAX.	0.067 MAX.
V	$0.55 \pm 0.1$	$0.022 \pm 0.004$
Y	$13.5 \pm 0.7$	$0.531 \pm 0.028$

**RECOMMENDED SOLDERING CONDITIONS**

The following conditions (see table below) must be met when soldering this product.

Please consult with our sales offices in case other soldering process is used, or in case soldering is done under different conditions.

**<TYPES OF THROUGH HOLE MOUNT DEVICE>**

[ $\mu$ PC78N00H Series]

Soldering process	Soldering condition	Symbol
Wave soldering	Solder temperature: 260 °C or below, Flow time: 10 seconds or below	

**Reference**

Application note name	No.
Quality control of NEC semiconductor devices	TEI-1202
Quality control guide of semiconductors devices	MEI-1202
Assembly manual of semiconductors devices	IEI-1207
NEC semiconductor device reliability/quality control system	IEI-1212

**[MEMO]**

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Application examples recommended by NEC Corporation.

Standard: Computer, Office equipment, Communication equipment, Test and Measurement equipment, Machine tools, Industrial robots, Audio and Visual equipment, Other consumer products, etc.

Special: Automotive and Transportation equipment, Traffic control systems, Antidisaster systems, Anticrime systems, etc.